

# Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

## **Quality Overview**

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
  - Class Q Military
  - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

# **Dual D-Type Positive Edge-Triggered Flip-Flop**

The SN74LS74A dual edge-triggered flip-flop utilizes Schottky TTL circuitry to produce high speed D-type flip-flops. Each flip-flop has individual clear and set inputs, and also complementary Q and  $\overline{Q}$  outputs.

Information at input D is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the HIGH or the LOW level, the D input signal has no effect.



## ON Semiconductor®

http://onsemi.com

LOW POWER SCHOTTKY



PLASTIC N SUFFIX CASE 646



SOIC D SUFFIX CASE 751A



SOEIAJ M SUFFIX CASE 965

#### **MODE SELECT - TRUTH TABLE**

OPERATING MODE		INPUTS	UTS OUTF			
OPERATING MODE	SD	CD	D	Q	Q	
Set	L	Н	Х	Н	L	
Reset (Clear)	Н	L	X	L	Н	
*Undetermined	L	L	X	Н	Н	
Load "1" (Set)	Н	Н	h	Н	L	
Load "0" (Reset)	Н	H		L	H	

\* Both outputs will be HIGH while both  $\overline{S}_D$  and  $\overline{C}_D$  are LOW, but the output states are unpredictable if  $\overline{S}_D$  and  $\overline{C}_D$  go HIGH simultaneously. If the levels at the set and clear are near  $V_{IL}$  maximum then we cannot guarantee to meet the minimum level for  $V_{OH}$ .

H, h = HIGH Voltage Level

L, I = LOW Voltage Level

X = Don't Care

I, h (q) = Lower case letters indicate the state of the referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

#### **GUARANTEED OPERATING RANGES**

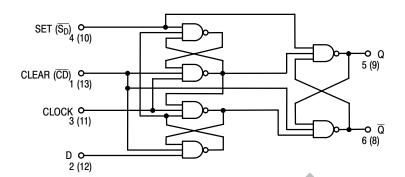
Symbol	Parameter	Min	Тур	Max	Unit
V <sub>CC</sub>	Supply Voltage	4.75	5.0	5.25	V
T <sub>A</sub>	T <sub>A</sub> Operating Ambient Temperature Range		25	70	°C
I <sub>OH</sub>	I <sub>OH</sub> Output Current – High			-0.4	mA
I <sub>OL</sub>	Output Current - Low			8.0	mA

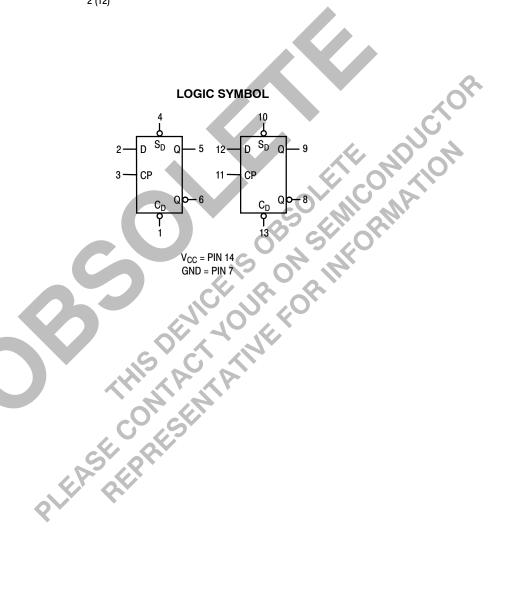
#### **ORDERING INFORMATION**

Device	Package	Shipping	
SN74LS74AN	14 Pin DIP	2000 Units/Box	
SN74LS74AD	SOIC-14	55 Units/Rail	
SN74LS74ADR2	SOIC-14	2500/Tape & Reel	
SN74LS74AM	SOEIAJ-14	See Note 1	
SN74LS74AMEL	SOEIAJ-14	See Note 1	

 For ordering information on the EIAJ version of the SOIC package, please contact your local ON Semiconductor representative.

#### LOGIC DIAGRAM (Each Flip-Flop)





### DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE (unless otherwise specified)

			Limits				
Symbol	Parameter	Min	Тур	Max	Unit	Test Co	onditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			٧	Guaranteed Input HIGH Voltage for All Inputs	
V <sub>IL</sub>	Input LOW Voltage			0.8	V	Guaranteed Input All Inputs	LOW Voltage for
V <sub>IK</sub>	Input Clamp Diode Voltage		-0.65	-1.5	V	$V_{CC} = MIN, I_{IN} = -$	- 18 mA
V <sub>OH</sub>	Output HIGH Voltage	2.7	3.5		V	$V_{CC}$ = MIN, $I_{OH}$ = MAX, $V_{IN}$ = $V_{IH}$ or $V_{IL}$ per Truth Table	
			0.25	0.4	V	I <sub>OL</sub> = 4.0 mA	V <sub>CC</sub> = V <sub>CC</sub> MIN,
V <sub>OL</sub>	Output LOW Voltage		0.35	0.5	V	I <sub>OL</sub> = 8.0 mA	V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> per Truth Table
I <sub>IH</sub>	Input High Current Data, Clock Set, Clear			20 40	μΑ	$V_{CC} = MAX, V_{IN} = 2.7 V$	
	Data, Clock Set, Clear			0.1 0.2	mA	V <sub>CC</sub> = MAX, V <sub>IN</sub> =	- 7.0 V
I <sub>IL</sub>	Input LOW Current Data, Clock Set, Clear			-0.4 -0.8	mA	V <sub>CC</sub> = MAX, V <sub>IN</sub> =	€ 0.4 V
I <sub>OS</sub>	Output Short Circuit Current (Note 2)	-20		-100	mA	V <sub>CC</sub> = MAX	
I <sub>CC</sub>	Power Supply Current			8.0	mA	V <sub>CC</sub> = MAX	

<sup>2.</sup> Not more than one output should be shorted at a time, nor for more than 1 second.

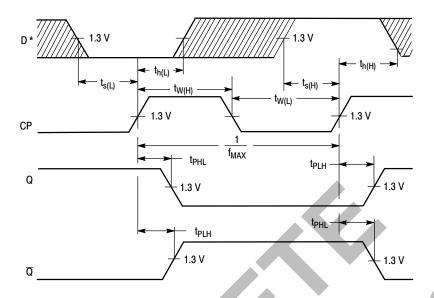
# AC CHARACTERISTICS (T<sub>A</sub> = 25°C, V<sub>CC</sub> = 5.0 V)

			Limits	7	191		
Symbol	Parameter	Min	Тур	Max	Unit	Test Co	onditions
f <sub>MAX</sub>	Maximum Clock Frequency	25	33		MHz	Figure 1	
t <sub>PLH</sub>	Clark Clark Catta Outrat		13	25	ns	Figure 4	$V_{CC} = 5.0 \text{ V}$ $C_L = 15 \text{ pF}$
t <sub>PHL</sub>	Clock, Clear, Set to Output	X	25	40	ns	Figure 1	ο <sub>L</sub> = 10 βι

# AC SETUP REQUIREMENTS (T<sub>A</sub> = 25°C)

	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	Limits					
Symbol	Parameter	Min	Тур	Max	Unit	Test Co	onditions
t <sub>W (H)</sub>	Clock	25			ns	Figure 1	
t <sub>W (L)</sub>	Clear, Set	25			ns	Figure 2	
+	Data Setup Time — HIGH	20			ns	Figure 1	V <sub>CC</sub> = 5.0 V
t <sub>s</sub>	LOW	20			ns	Figure 1	
t <sub>h</sub>	Hold Time	5.0			ns	Figure 1	

#### **AC WAVEFORMS**



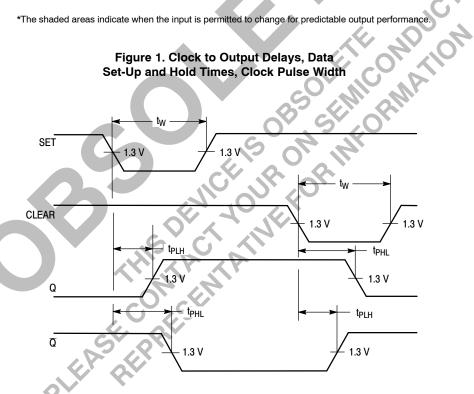
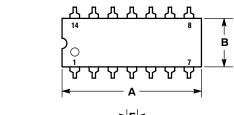
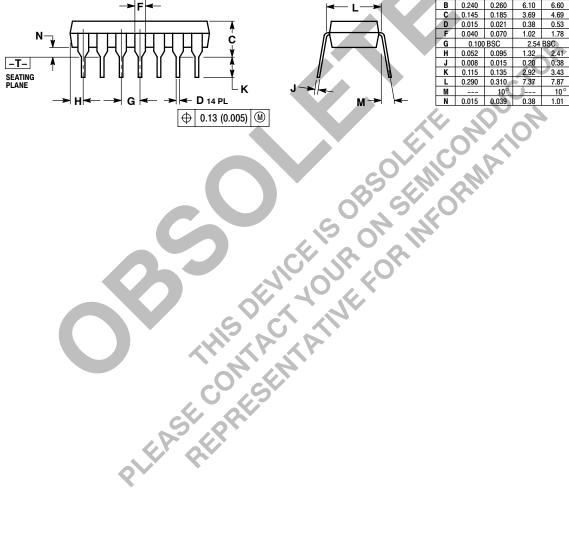


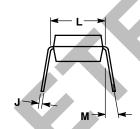
Figure 2. Set and Clear to Output Delays, Set and Clear Pulse Widths

#### PACKAGE DIMENSIONS

#### **N SUFFIX** PLASTIC PACKAGE CASE 646-06 ISSUE M







#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
  Y14.5M. 1982.
- Y14.5M, 1982.

  CONTROLLING DIMENSION: INCH.

  DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.

  DIMENSION B DOES NOT INCLUDE MOLD FLASH.

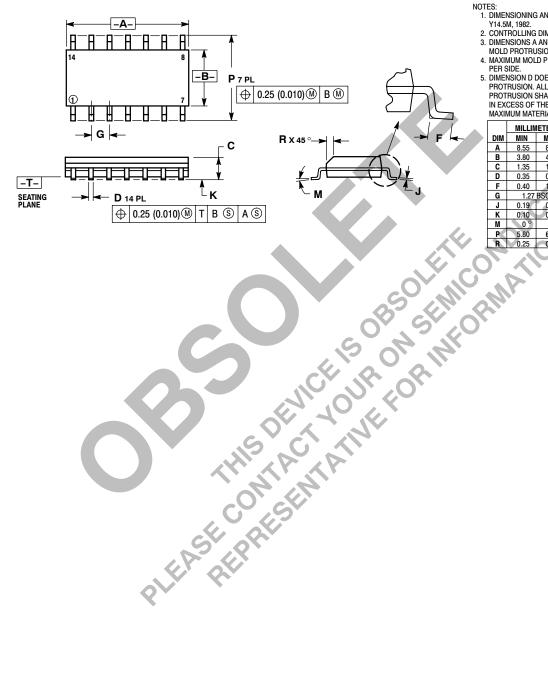
  ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIMETER			
DIM	MIN	MAX	MIN	MAX		
Α	0.715	0.770	18.16	18.80		
В	0.240	0.260	6.10	6.60		
C	0.145	0.185	3.69	4.69		
D	0.015	0.021	0.38	0.53		
F	0.040	0.070	1.02	1.78		
G	0.100	BSC	2.54	BSC		
Н	0.052	0.095	1.32	2.41		
J	0.008	0.015	0.20	0.38		
K	0.115	0.135	2.92	3.43		
L	0.290	0.310	7.37	7.87		
M		10°	1	10°		
N	0.015	0.039	0.38	1.01		

#### PACKAGE DIMENSIONS

#### **D SUFFIX**

PLASTIC SOIC PACKAGE CASE 751A-03 **ISSUE F** 



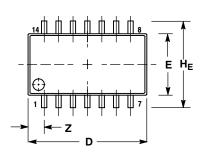
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER.
- 3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
- 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.

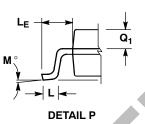
	IN EX	RUSION : CESS OF MUM MAT	MENSIÒN	I AT				
		MILLIMETERS INCHES						
	DIM	MIN	MAX	MIN	MAX			
	Α	8.55	8.75	0.337	0.344			
B 3.80 4.00 0.150 0.15								
	С	1.35	1.75	0.054	0.068			

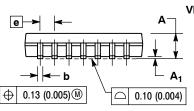
#### PACKAGE DIMENSIONS

#### **M SUFFIX**

SOEIAJ PACKAGE CASE 965-01 **ISSUE O** 









- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH DIMENSION AT MAXIMUM MATERIAL CONDITION DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 ( 0.018).

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	-	2.05		0.081
A <sub>1</sub>	0.05	0.20	0.002	0.008
b	0.35	0.50	0.014	0.020
C	0.18	0.27	0.007	0.011
D	9.90	10.50	0.390	0.413
E	5.10	5.45	0.201	0.215
е	1.27	BSC	0.050	BSC
HE	7.40	8.20	0.291	0.323
0.50	0.50	0.85	0.020	0.033
LE.	1.10	1.50	0.043	0.059
M	0 °	10 °	0 °	10°
$Q_1$	0.70	0.90	0.028	0.035
Ž		1.42		0.056

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